

DATA SHEET

For a complete data sheet, please also download:

- The IC06 74HC/HCT/HCU/HCMOS Logic Family Specifications
- The IC06 74HC/HCT/HCU/HCMOS Logic Package Information
- The IC06 74HC/HCT/HCU/HCMOS Logic Package Outlines

74HC/HCT4351 8-channel analog multiplexer/demultiplexer with latch

Product specification
File under Integrated Circuits, IC06

December 1990

8-channel analog multiplexer/demultiplexer with latch

74HC/HCT4351

FEATURES

- Wide analog input voltage range:
 ± 5 V
- Low "ON" resistance:
80 Ω (typ.) at $V_{CC} - V_{EE} = 4.5$ V
70 Ω (typ.) at $V_{CC} - V_{EE} = 6.0$ V
60 Ω (typ.) at $V_{CC} - V_{EE} = 9.0$ V
- Logic level translation: to enable 5 V logic to communicate with ± 5 V analog signals
- Typical "break before make" built in
- Address latches provided
- Output capability: non-standard
- I_{CC} category: MSI

GENERAL DESCRIPTION

The 74HC/HCT4351 are high-speed Si-gate CMOS devices. They are specified in compliance with JEDEC standard no. 7A.

The 74HC/HCT4351 are 8-channel analog multiplexers/demultiplexers with three select inputs (S_0 to S_2), two enable inputs (\bar{E}_1 and E_2), a latch enable input (\bar{LE}), eight independent inputs/outputs (Y_0 to Y_7) and a common input/output (Z).

With \bar{E}_1 LOW and E_2 is HIGH, one of the eight switches is selected (low impedance ON-state) by S_0 to S_2 . The data at the select inputs may be latched by using the active LOW latch enable input (\bar{LE}). When \bar{LE} is HIGH the latch is transparent. When either of the two enable inputs, \bar{E}_1 (active LOW) and E_2 (active HIGH), is inactive, all 8 analog switches are turned off.

V_{CC} and GND are the supply voltage pins for the digital control inputs (S_0 to S_2 , \bar{LE} , \bar{E}_1 and E_2). The V_{CC} to GND ranges are 2.0 to 10.0 V for HC and 4.5 to 5.5 V for HCT. The analog inputs/outputs (Y_0 to Y_7 , and Z) can swing between V_{CC} as a positive limit and V_{EE} as a negative limit.

$V_{CC} - V_{EE}$ may not exceed 10.0 V.

For operation as a digital multiplexer/demultiplexer, V_{EE} is connected to GND (typically ground).

QUICK REFERENCE DATA

$V_{EE} = \text{GND} = 0$ V; $T_{\text{amb}} = 25$ °C; $t_r = t_f = 6$ ns

SYMBOL	PARAMETER	CONDITIONS	TYPICAL		UNIT
			HC	HCT	
t_{PZH} / t_{PZL}	turn "ON" time \bar{E}_1 , E_2 or S_n to V_{os}	$C_L = 15$ pF; $R_L = 1$ k Ω ; $V_{CC} = 5$ V	27	35	ns
t_{PHZ} / t_{PLZ}	turn "OFF" time \bar{E}_1 , E_2 or S_n to V_{os}		21	23	ns
C_I	input capacitance		3.5	3.5	pF
C_{PD}	power dissipation capacitance per switch	notes 1 and 2	25	25	pF
C_S	max. switch capacitance independent (Y)		5	5	pF
	common (Z)		25	25	pF

Notes

1. C_{PD} is used to determine the dynamic power dissipation (P_D in μ W):

$$P_D = C_{PD} \times V_{CC}^2 \times f_i + \sum \{(C_L + C_S) \times V_{CC}^2 \times f_o\}$$

where:

f_i = input frequency in MHz

f_o = output frequency in MHz

C_L = output load capacitance in pF

C_S = max. switch capacitance in pF

$\sum \{(C_L + C_S) \times V_{CC}^2 \times f_o\}$ = sum of outputs

V_{CC} = supply voltage in V

2. For HC the condition is $V_I = \text{GND}$ to V_{CC}
For HCT the condition is $V_I = \text{GND}$ to $V_{CC} - 1.5$ V

ORDERING INFORMATION

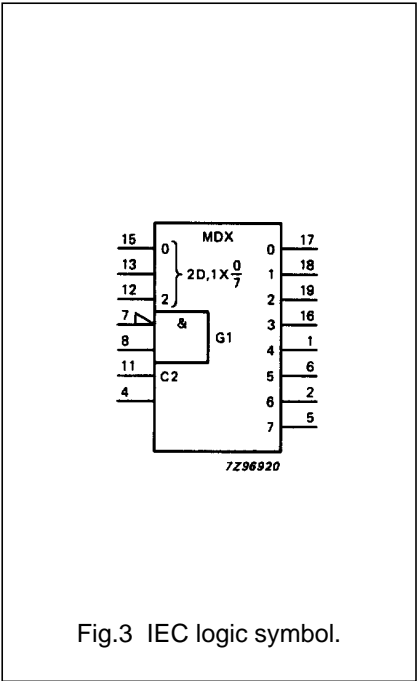
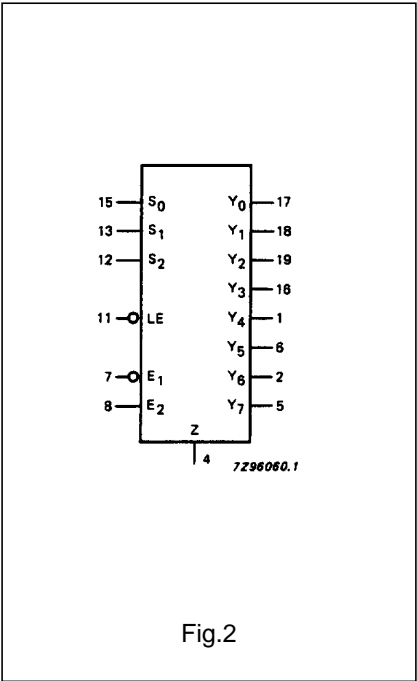
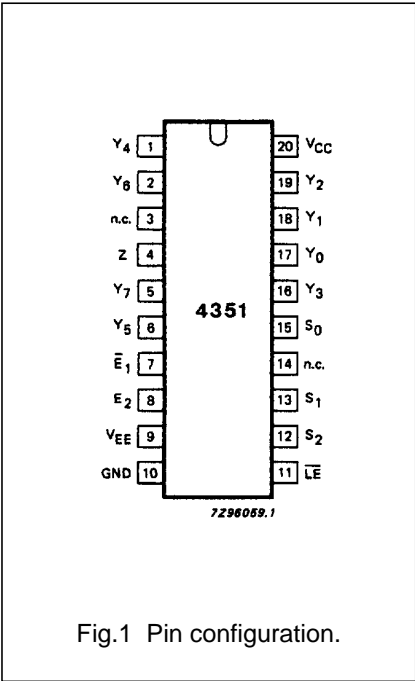
See "74HC/HCT/HCU/HCMOS Logic Package Information".

8-channel analog multiplexer/demultiplexer
with latch

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PIN DESCRIPTION

PIN NO.	SYMBOL	NAME AND FUNCTION
4	Z	common
3, 14	n.c.	not connected
7	\overline{E}_1	enable input (active LOW)
8	E ₂	enable input (active HIGH)
9	V _{EE}	negative supply voltage
10	GND	ground (0 V)
11	\overline{LE}	latch enable input (active LOW)
15, 13, 12	S ₀ to S ₂	select inputs
17, 18, 19, 16, 1, 6, 2, 5	Y ₀ to Y ₇	independent inputs/outputs
20	V _{CC}	positive supply voltage



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FUNCTION TABLE

INPUTS						CHANNEL ON
\overline{E}_1	E_2	\overline{LE}	S_2	S_1	S_0	
H	X	X	X	X	X	none
X	L	X	X	X	X	none
L	H	H	L	L	L	Y_0
L	H	H	L	L	H	Y_1
L	H	H	L	H	L	Y_2
L	H	H	L	H	H	Y_3
L	H	H	H	L	L	Y_4
L	H	H	H	L	H	Y_5
L	H	H	H	H	L	Y_6
L	H	H	H	H	H	Y_7
L	H	L	X	X	X	(1)
X	X	↓	X	X	X	(2)

Notes

1. Last selected channel "ON".
2. Selected channels latched.
3. H = HIGH voltage level
L = LOW voltage level
X = don't care
↓ = HIGH-to-LOW \overline{LE} transition

APPLICATIONS

- Analog multiplexing and demultiplexing
- Digital multiplexing and demultiplexing
- Signal gating

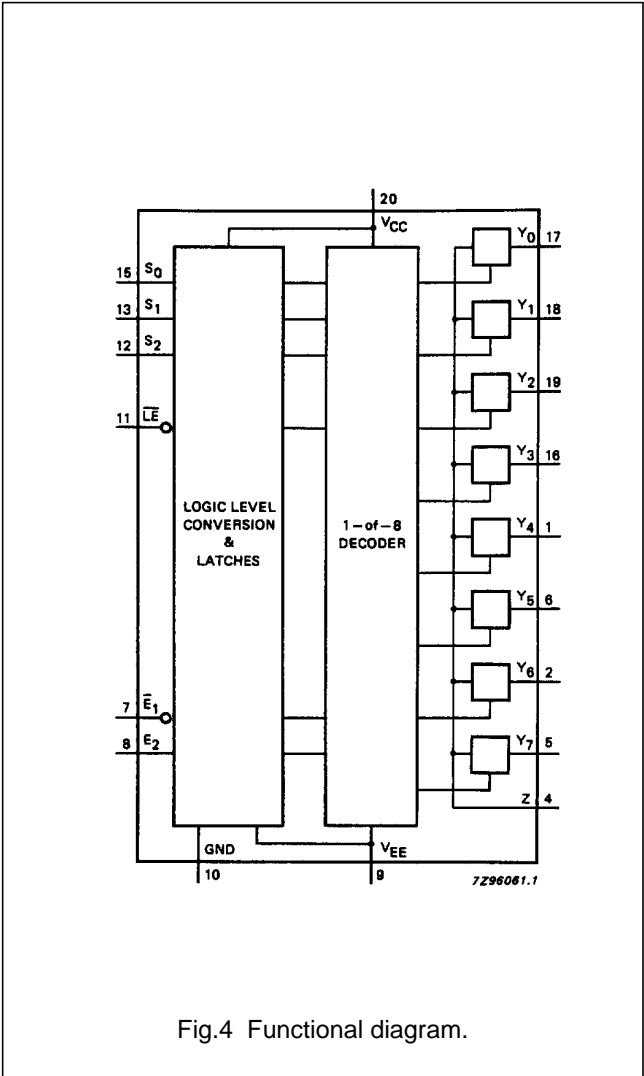


Fig.4 Functional diagram.

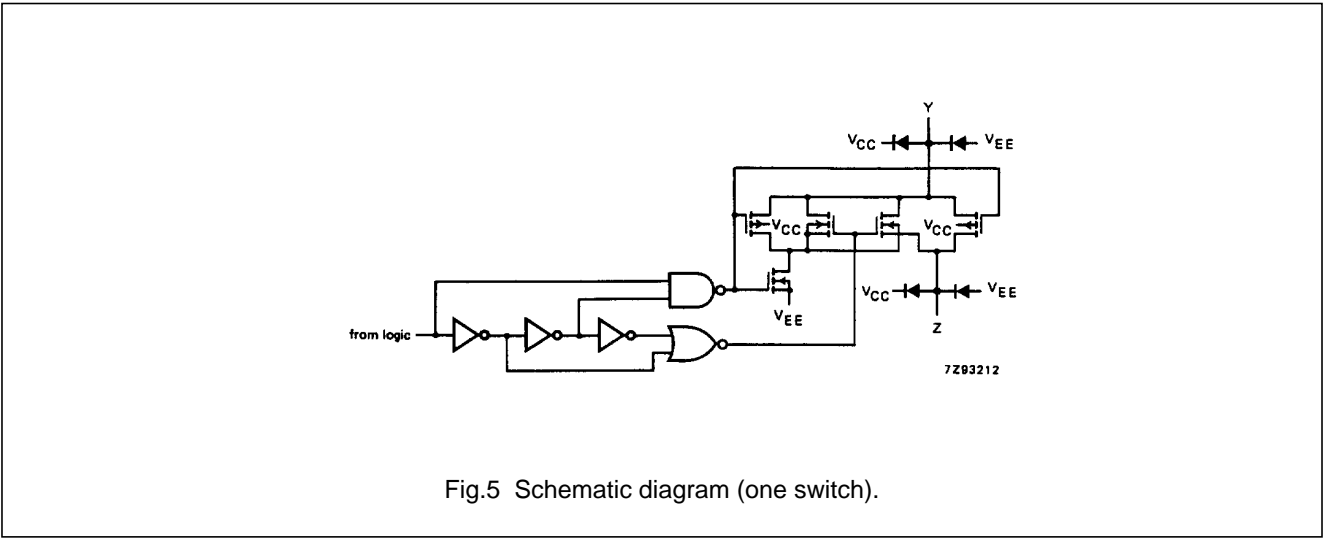


Fig.5 Schematic diagram (one switch).

8-channel analog multiplexer/demultiplexer with latch

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RATINGS

Limiting values in accordance with the Absolute Maximum System (IEC 134)

Voltages are referenced to $V_{EE} = \text{GND}$ (ground = 0 V)

SYMBOL	PARAMETER	MIN.	MAX.	UNIT	CONDITIONS
V_{CC}	DC supply voltage	-0.5	+11.0	V	
$\pm I_{IK}$	DC digital input diode current		20	mA	for $V_I < -0.5 \text{ V}$ or $V_I > V_{CC} + 0.5 \text{ V}$
$\pm I_{SK}$	DC switch diode current		20	mA	for $V_S < -0.5 \text{ V}$ or $V_S > V_{CC} + 0.5 \text{ V}$
$\pm I_S$	DC switch current		25	mA	for $-0.5 \text{ V} < V_S < V_{CC} + 0.5 \text{ V}$
$\pm I_{EE}$	DC V_{EE} current		20	mA	
$\pm I_{CC}; \pm I_{GND}$	DC V_{CC} or GND current		50	mA	
T_{stg}	storage temperature range	-65	+150	°C	
P_{tot}	power dissipation per package				for temperature range: -40 to +125 °C 74HC/HCT
	plastic DIL		750	mW	above +70 °C: derate linearly with 12 mW/K
	plastic mini-pack (SO)		500	mW	above +70 °C: derate linearly with 8 mW/K
P_S	power dissipation per switch		100	mW	

Note to ratings

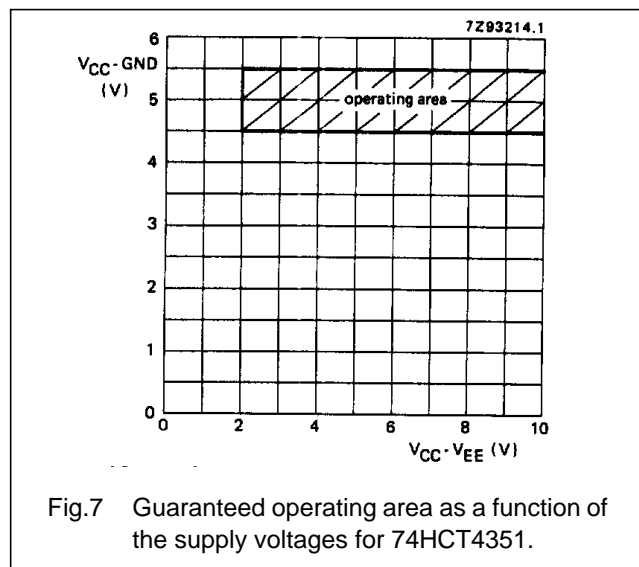
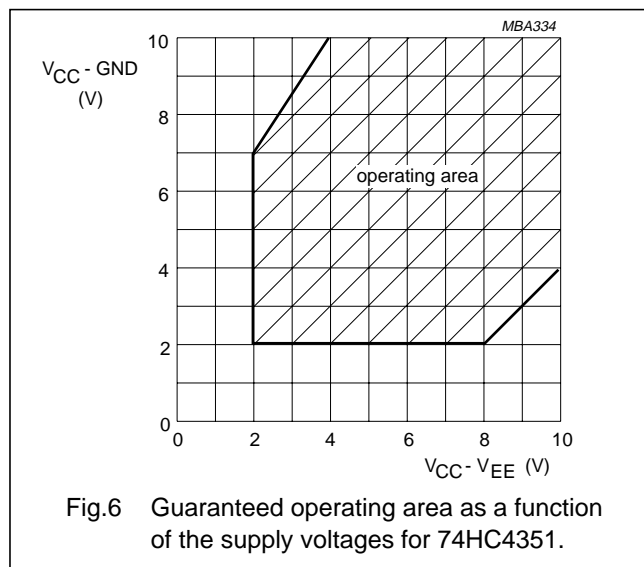
- To avoid drawing V_{CC} current out of terminal Z, when switch current flows in terminals Y_n , the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into terminal Z, no V_{CC} current will flow out of terminals Y_n . In this case there is no limit for the voltage drop across the switch, but the voltages at Y_n and Z may not exceed V_{CC} or V_{EE} .

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	74HC			74HCT			UNIT	CONDITIONS
		min.	typ.	max.	min.	typ.	max.		
V_{CC}	DC supply voltage $V_{CC}-\text{GND}$	2.0	5.0	10.0	4.5	5.0	5.5	V	see Figs 6 and 7
V_{CC}	DC supply voltage $V_{CC}-V_{EE}$	2.0	5.0	10.0	2.0	5.0	10.0	V	see Figs 6 and 7
V_I	DC input voltage range	GND		V_{CC}	GND		V_{CC}	V	
V_S	DC switch voltage range	V_{EE}		V_{CC}	V_{EE}		V_{CC}	V	
T_{amb}	operating ambient temperature range	-40		+85	-40		+85	°C	see DC and AC CHARACTERISTICS
T_{amb}	operating ambient temperature range	-40		+125	-40		+125	°C	
t_r, t_f	input rise and fall times		6.0	1000 500 400 250		6.0	500	ns	$V_{CC} = 2.0 \text{ V}$ $V_{CC} = 4.5 \text{ V}$ $V_{CC} = 6.0 \text{ V}$ $V_{CC} = 10.0 \text{ V}$

8-channel analog multiplexer/demultiplexer with latch

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DC CHARACTERISTICS FOR 74HC/HCT

For 74HC: $V_{CC} - GND$ or $V_{CC} - V_{EE} = 2.0, 4.5, 6.0$ and 9.0 V

For 74HCT: $V_{CC} - GND = 4.5$ and 5.5 V; $V_{CC} - V_{EE} = 2.0, 4.5, 6.0$ and 9.0 V

SYMBOL	PARAMETER	T _{amb} (°C)							UNIT	TEST CONDITIONS				
		74HC/HCT								V _{CC} (V)	V _{EE} (V)	I _S (μA)	V _{is}	V _I
		+25			−40 to +85		−40 to +125							
		min.	typ.	max.	min.	max.	min.	max.						
R _{ON}	ON resistance (rail)		—	—		—		—	Ω	2.0	0	100	V _{CC} to V _{EE}	V _{IN} or V _{IL}
			100	180		225		270	Ω	4.5	0	1000		
			90	160		200		240	Ω	6.0	0	1000		
			70	130		165		195	Ω	4.5	−4.5	1000		
R _{ON}	ON resistance (rail)		150	—		—		—	Ω	2.0	0	100	V _{EE}	V _{IH} or V _{IL}
			80	140		175		210	Ω	4.5	0	1000		
			70	120		150		180	Ω	6.0	0	1000		
			60	105		130		160	Ω	4.5	−4.5	1000		
R _{ON}	ON resistance (rail)		150	—		—		—	Ω	2.0	0	100	V _{CC}	V _{IH} or V _{IL}
			90	160		200		240	Ω	4.5	0	1000		
			80	140		175		210	Ω	6.0	0	1000		
			65	120		150		180	Ω	4.5	−4.5	1000		
ΔR _{ON}	maximum Δ ON resistance between any two channels		—						Ω	2.0	0		V _{CC} to V _{EE}	V _{IH} or V _{IL}
			9						Ω	4.5	0			
			8						Ω	6.0	0			
			6						Ω	4.5	−4.5			

Notes to DC characteristics

- At supply voltages ($V_{CC} - V_{EE}$) approaching 2.0 V, the analog switch ON-resistance becomes extremely non-linear. There it is recommended that these devices be used to transmit digital signals only, when using these supply voltages.
- For test circuit measuring R_{ON} see Fig.8.

8-channel analog multiplexer/demultiplexer with latch

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DC CHARACTERISTICS FOR 74HC

Voltages are referenced to GND (ground = 0 V)

SYMBOL	PARAMETER	T _{amb} (°C)							UNIT	TEST CONDITIONS			
		74HC								V _{CC} (V)	V _{EE} (V)	V _I	OTHER
		+25			−40 to +85		−40 to +125						
		min.	typ.	max.	min.	max.	min.	max.					
V _{IH}	HIGH level input voltage	1.5 3.15 4.2 6.3	1.2 2.4 3.2 4.7		1.5 3.15 4.2 6.3		1.5 3.15 4.2 6.3		V	2.0 4.5 6.0 9.0			
V _{IL}	LOW level input voltage		0.8 2.1 2.8 4.3	0.5 1.35 1.8 2.7		0.5 1.35 1.8 2.7		0.5 1.35 1.8 2.7	V	2.0 4.5 6.0 9.0			
±I _I	input leakage current			0.1 0.2		1.0 2.0		1.0 2.0	μA	6.0 10.0	0 0	V _{CC} or GND	
±I _S	analog switch OFF-state current per channel			0.1		1.0		1.0	μA	10.0	0	V _{IH} or V _{IL}	V _S = V _{CC} − V _{EE} (see Fig.10)
±I _S	analog switch OFF-state current all channels			0.4		4.0		4.0	μA	10.0	0	V _{IH} or V _{IL}	V _S = V _{CC} − V _{EE} (see Fig.10)
±I _S	analog switch ON-state current			0.4		4.0		4.0	μA	10.0	0	V _{IH} or V _{IL}	V _S = V _{CC} − V _{EE} (see Fig.11)
I _{CC}	quiescent supply current			8.0 16.0		80.0 160.0		160.0 320.0	μA	6.0 10.0	0 0	V _{CC} or GND	V _{IS} = V _{EE} or V _{CC} ; V _{OS} = V _{CC} or V _{EE}

8-channel analog multiplexer/demultiplexer with latch

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AC CHARACTERISTICS FOR 74HCGND = 0 V; $t_r = t_f = 6$ ns; $C_L = 50$ pF

SYMBOL	PARAMETER	T _{amb} (°C)							UNIT	TEST CONDITIONS		
		74HC								V _{CC} (V)	V _{EE} (V)	OTHER
		+25			−40 to +85		−40 to +125					
		min.	typ.	max.	min.	max.	min.	max.				
t _{PHL} / t _{PLH}	propagation delay V _{is} to V _{os}		14	60		75		90	ns	2.0	0	R _L = ∞; C _L = 50 pF (see Fig.17)
			5	12		15		18				
			4	10		13		15				
			4	8		10		12				
t _{PZH} / t _{PZL}	turn “ON” time E ₁ to V _{os}		85	300		375		450	ns	2.0	0	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
			31	60		75		90				
			25	51		64		77				
			28	55		69		83				
t _{PZH} / t _{PZL}	turn “ON” time E ₂ to V _{os}		85	300		375		450	ns	2.0	0	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
			31	60		75		90				
			25	51		64		77				
			25	55		69		83				
t _{PZH} / t _{PZL}	turn “ON” time LE to V _{os}		91	300		375		450	ns	2.0	0	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
			33	60		75		90				
			26	51		64		77				
			27	55		69		83				
t _{PZH} / t _{PZL}	turn “ON” time S _n to V _{os}		88	300		375		450	ns	2.0	0	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
			32	60		75		90				
			26	51		64		77				
			25	50		63		75				
t _{PHZ} / t _{PLZ}	turn “OFF” time E ₁ to V _{os}		69	250		315		375	ns	2.0	0	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
			25	50		63		75				
			20	43		54		64				
			20	40		50		60				
t _{PHZ} / t _{PLZ}	turn “OFF” time E ₂ to V _{os}		72	250		315		375	ns	2.0	0	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
			26	50		63		75				
			21	43		54		64				
			19	40		50		60				
t _{PHZ} / t _{PLZ}	turn “OFF” time LE to V _{os}		83	275		345		415	ns	2.0	0	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
			30	55		69		83				
			24	47		59		71				
			26	45		56		68				
t _{PHZ} / t _{PLZ}	turn “OFF” time S _n to V _{os}		80	275		345		415	ns	2.0	0	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
			29	55		69		83				
			23	47		59		71				
			24	48		60		72				

8-channel analog multiplexer/demultiplexer with latch

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SYMBOL	PARAMETER	T _{amb} (°C)							UNIT	TEST CONDITIONS		
		74HC								V _{CC} (V)	V _{EE} (V)	OTHER
		+25			−40 to +85		−40 to +125					
		min.	typ.	max.	min.	max.	min.	max.				
t _{su}	set-up time S _n to $\overline{\text{LE}}$	60	17			75		90	ns	2.0	0	R _L = 1 kΩ; C _L = 50 pF (see Fig.19)
		12	6			15		18		4.5	0	
		10	5			13		15		6.0	0	
		18	9			23		27		4.5	−4.5	
t _h	hold time S _n to $\overline{\text{LE}}$	5	−8			5		5	ns	2.0	0	R _L = 1 kΩ; C _L = 50 pF (see Fig.19)
		5	−3			5		5		4.5	0	
		5	−2			5		5		6.0	0	
		5	−4			5		5		4.5	−4.5	
t _w	$\overline{\text{LE}}$ minimum pulse width HIGH	100	11			125		150	ns	2.0	0	R _L = 1 kΩ; C _L = 50 pF (see Fig.19)
		20	1			25		30		4.5	0	
		17	3			21		26		6.0	0	
		25	7			31		38		4.5	−4.5	

8-channel analog multiplexer/demultiplexer with latch

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DC CHARACTERISTICS FOR 74HCT

Voltages are referenced to GND (ground = 0)

SYMBOL	PARAMETER	T _{amb} (°C)							UNIT	TEST CONDITIONS			
		74HCT								V _{CC} (V)	V _{EE} (V)	V _I	OTHER
		+25			−40 to +85		−40 to +125						
		min.	typ.	max.	min.	max.	min.	max.					
V _{IH}	HIGH level input voltage	2.0	1.6		2.0		2.0		V	4.5 to 5.5			
V _{IL}	LOW level input voltage		1.2	0.8		0.8		0.8	V	4.5 to 5.5			
±I _I	input leakage current			0.1		1.0		1.0	μA	5.5	0	V _{CC} or GND	
±I _S	analog switch OFF-state current per channel			0.1		1.0		1.0	μA	10.0	0	V _{IH} or V _{IL}	I _S = V _{CC} − V _{EE} (see Fig.10)
±I _S	analog switch OFF-state current all channels			0.4		4.0		4.0	μA	10.0	0	V _{IH} or V _{IL}	I _S = V _{CC} − V _{EE} (see Fig.10)
±I _S	analog switch ON-state current			0.4		4.0		4.0	μA	10.0	0	V _{IH} or V _{IL}	I _S = V _{CC} − V _{EE} (see Fig.11)
I _{CC}	quiescent supply current			8.0 16.0		80.0 160.0		160.0 320.0	μA	5.5 5.0	0 −5.0	V _{CC} or GND	V _{IS} = V _{EE} or V _{CC} ; V _{OS} = V _{CC} or V _{EE}
ΔI _{CC}	additional quiescent supply current per input pin for unit load coefficient is 1 (note 1)		100	360		450		490	μA	4.5 to 5.5	0	V _{CC} −2.1 V	other inputs at V _{CC} or GND

Note to HCT types

- The value of additional quiescent supply current (ΔI_{CC}) for a unit load of 1 is given here.
To determine ΔI_{CC} per input, multiply this value by the unit load coefficient shown in the table below.

INPUT	UNIT LOAD COEFFICIENT
\overline{E}_1, E_2	0.50
S_n	0.50
\overline{LE}	1.5

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AC CHARACTERISTICS FOR 74HCTGND = 0 V; $t_r = t_f = 6$ ns; $C_L = 50$ pF

SYMBOL	PARAMETER	T _{amb} (°C)							UNIT	TEST CONDITIONS		
		74HCT								V _{CC} (V)	V _{EE} (V)	OTHER
		+25			−40 to +85		−40 to +125					
		min.	typ.	max.	min.	max.	min.	max.				
t _{PHL} / t _{PLH}	propagation delay V _{is} to V _{os}		6 4	12 8		15 10		18 12	ns	4.5 4.5	0 −4.5	R _L = ∞; C _L = 50 pF (see Fig.17)
t _{PZH} / t _{PZL}	turn “ON” time E ₁ to V _{os}		40 31	75 60		94 75		113 90	ns	4.5 4.5	0 −4.5	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
t _{PZH} / t _{PZL}	turn “ON” time E ₂ to V _{os}		35 26	70 50		88 63		105 75	ns	4.5 4.5	0 −4.5	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
t _{PZH} / t _{PZL}	turn “ON” time LE to V _{os}		42 37	75 60		94 75		113 90	ns	4.5 4.5	0 −4.5	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
t _{PZH} / t _{PZL}	turn “ON” time S _n to V _{os}		39 30	75 60		94 75		113 90	ns	4.5 4.5	0 −4.5	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
t _{PHZ} / t _{PLZ}	turn “OFF” time E ₁ to V _{os}		27 20	55 40		69 50		83 60	ns	4.5 4.5	0 −4.5	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
t _{PHZ} / t _{PLZ}	turn “OFF” time E ₂ to V _{os}		32 26	60 50		75 63		90 75	ns	4.5 4.5	0 −4.5	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
t _{PHZ} / t _{PLZ}	turn “OFF” time LE to V _{os}		33 30	60 55		75 69		90 83	ns	4.5 4.5	0 −4.5	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
t _{PHZ} / t _{PLZ}	turn “OFF” time S _n to V _{os}		33 29	65 55		81 69		98 83	ns	4.5 4.5	0 −4.5	R _L = 1 kΩ; C _L = 50 pF (see Fig.18)
t _{su}	set-up time S _n to LE	12 14	6 7			15 18		18 21	ns	4.5 4.5	0 −4.5	R _L = 1 kΩ; C _L = 50 pF (see Fig.19)
t _h	hold time S _n to LE	5 5	−1 −2			5 5		5 5	ns	4.5 4.5	0 −4.5	R _L = 1 kΩ; C _L = 50 pF (see Fig.19)
t _w	LE minimum pulse width HIGH	25 25	13 13			31 31		38 38	ns	4.5 4.5	0 −4.5	R _L = 1 kΩ; C _L = 50 pF (see Fig.19)

8-channel analog multiplexer/demultiplexer with latch

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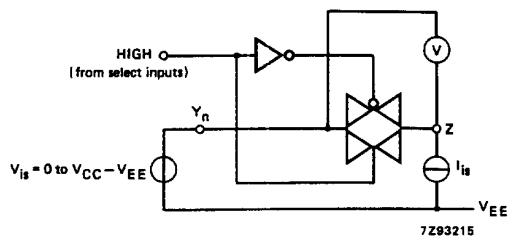
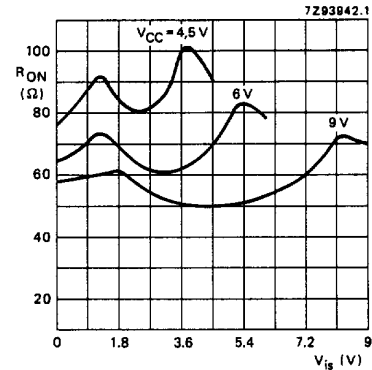
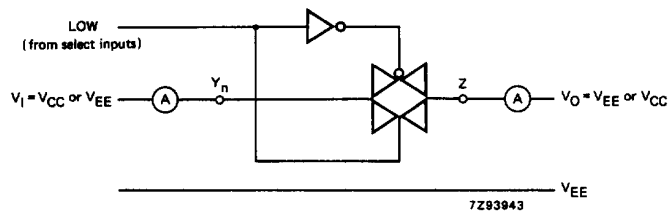
Fig.8 Test circuit for measuring R_{ON} .Fig.9 Typical R_{ON} as a function of input voltage V_{is} for $V_{is} = 0$ to $V_{CC} - V_{EE}$.

Fig.10 Test circuit for measuring OFF-state current.

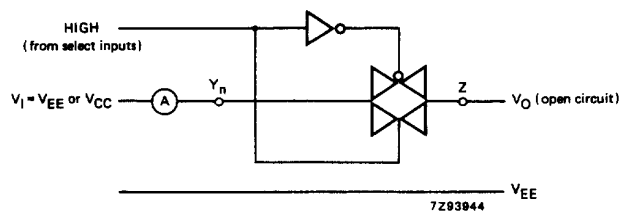


Fig.11 Test circuit for measuring ON-state current.

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ADDITIONAL AC CHARACTERISTICS FOR 74HC/HCT

Recommended conditions and typical values

GND = 0 V; $T_{amb} = 25\text{ }^{\circ}\text{C}$

SYMBOL	PARAMETER	typ.	UNIT	V_{CC} (V)	V_{EE} (V)	$V_{is(p-p)}$ (V)	CONDITIONS
	sine-wave distortion $f = 1\text{ kHz}$	0.04 0.02	% %	2.25 4.5	-2.25 -4.5	4.0 8.0	$R_L = 10\text{ k}\Omega$; $C_L = 50\text{ pF}$ (see Fig.14)
	sine-wave distortion $f = 10\text{ kHz}$	0.12 0.06	% %	2.25 4.5	-2.25 -4.5	4.0 8.0	$R_L = 10\text{ k}\Omega$; $C_L = 50\text{ pF}$ (see Fig.14)
	switch "OFF" signal feed-through	-50 -50	dB dB	2.25 4.5	-2.25 -4.5	note 1	$R_L = 600\text{ }\Omega$; $C_L = 50\text{ pF}$ (see Figs 12 and 15)
$V_{(p-p)}$	crosstalk voltage between control and any switch (peak-to-peak value)	120 220	mV mV	4.5 4.5	0 -4.5		$R_L = 600\text{ }\Omega$; $C_L = 50\text{ pF}$; $f = 1\text{ MHz}$ (E_1 , E_2 or S_n , square-wave between V_{CC} and GND, $t_r = t_f = 6\text{ ns}$) (see Fig.16)
f_{max}	minimum frequency response (-3dB)	160 170	MHz MHz	2.25 4.5	-2.25 -4.5	note 2	$R_L = 50\text{ }\Omega$; $C_L = 10\text{ pF}$ (see Figs 13 and 14)
C_S	maximum switch capacitance independent (Y) common (Z)	5 25	pF pF				

Notes to AC characteristics

1. Adjust input voltage V_{is} to 0 dBm level (0 dBm = 1 mW into 600 Ω).
2. Adjust input voltage V_{is} to 0 dBm level at V_{os} for 1 MHz (0 dBm = 1 mW into 50 Ω).

V_{is} is the input voltage at a Y_n or Z terminal, whichever is assigned as an input.

V_{os} is the output voltage at a Y_n or Z terminal, whichever is assigned as an output.

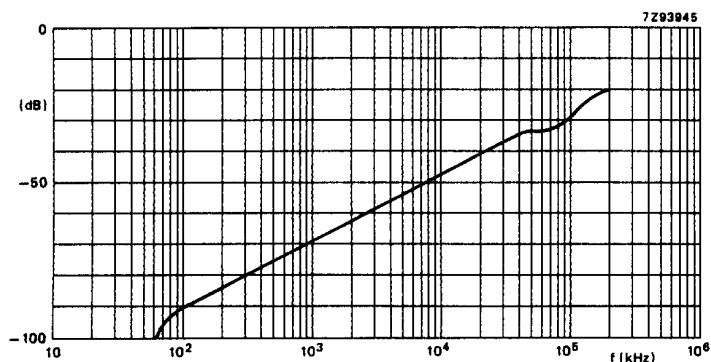


Fig.12 Typical switch "OFF" signal feed-through as a function of frequency.

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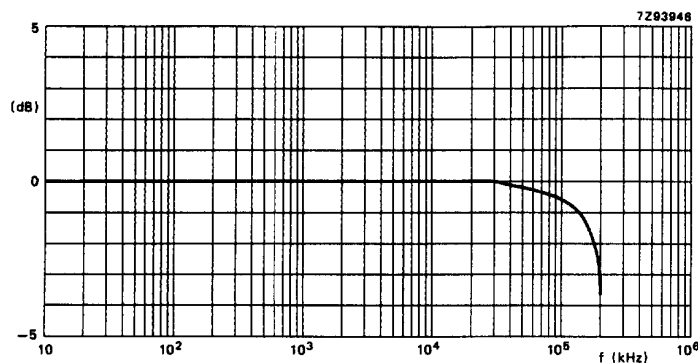


Fig.13 Typical frequency response.

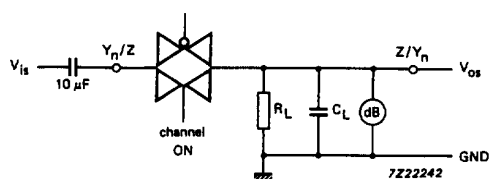


Fig.14 Test circuit for measuring sine-wave distortion and minimum frequency response.

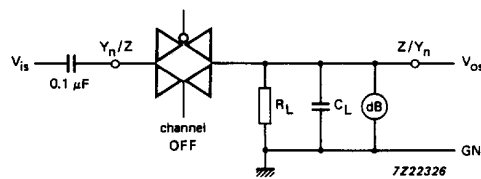
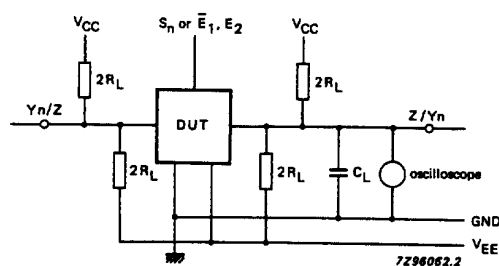


Fig.15 Test circuit for measuring switch "OFF" signal feed-through.



The crosstalk is defined as follows
(oscilloscope output):

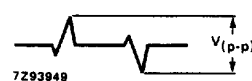


Fig.16 Test circuit for measuring crosstalk between control and any switch.

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AC WAVEFORMS

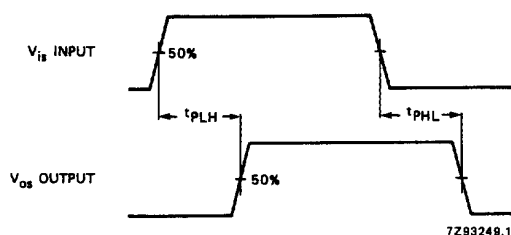
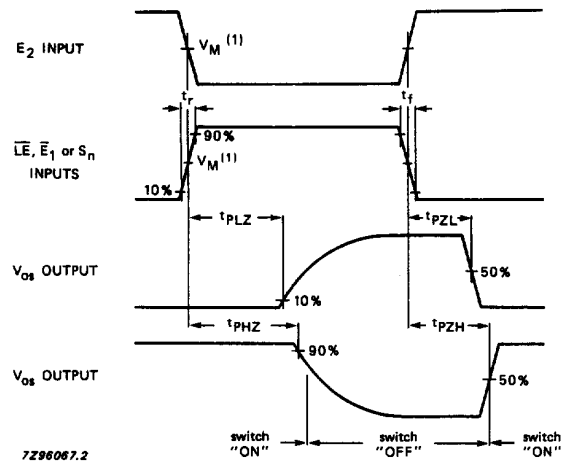
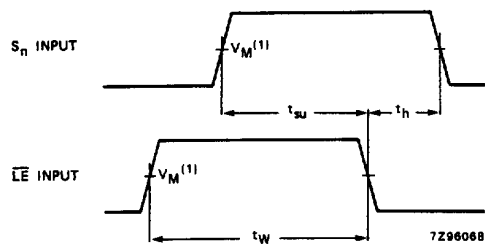


Fig.17 Waveforms showing the input (V_{is}) to output (V_{os}) propagation delays.



HC : $V_M = 50\%$; $V_I = \text{GND to } V_{CC}$.
HCT: $V_M = 1.3 \text{ V}$; $V_I = \text{GND to } 3 \text{ V}$.

Fig.18 Waveforms showing the turn-ON and turn-OFF times.



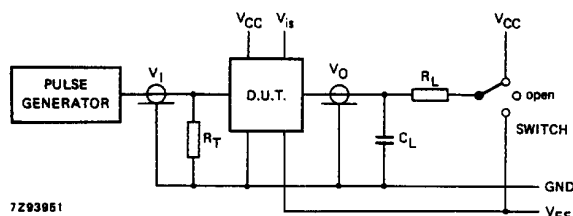
HC : $V_M = 50\%$; $V_I = \text{GND to } V_{CC}$.
HCT: $V_M = 1.3 \text{ V}$; $V_I = \text{GND to } 3 \text{ V}$.

Fig.19 Waveforms showing the set-up and hold times from S_n inputs to \overline{LE} input, and minimum pulse width of \overline{LE} .

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TEST CIRCUIT AND WAVEFORMS



Conditions

TEST	SWITCH	V _{is}
t _{PZH}	V _{EE}	V _{CC}
t _{PZL}	V _{CC}	V _{EE}
t _{PHZ}	V _{EE}	V _{CC}
t _{PLZ}	V _{CC}	V _{EE}
others	open	pulse

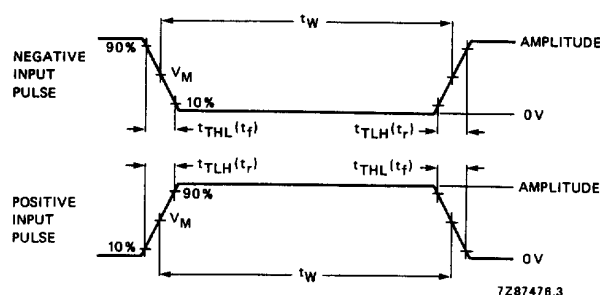
FAMILY	AMPLITUDE	V_M	$t_r; t_f$	
			$f_{max};$ PULSE WIDTH	OTHER
74HC	V_{CC}	50%	< 2 ns	6 ns
74HCT	3.0 V	1.3 V	< 2 ns	6 ns

C_L = load capacitance including jig and probe capacitance (see AC CHARACTERISTICS for values).

R_T = termination resistance should be equal to the output impedance Z_O of the pulse generator.

$t_r = t_f = 6 \text{ ns}$; when measuring f_{\max} , there is no constraint on t_r, t_f with 50% duty factor.

Fig.20 Test circuit for measuring AC performance.



Conditions

TEST	SWITCH	V_{is}
t _{PZH}	V_{EE}	V_{CC}
t _{PZL}	V_{CC}	V_{EE}
t _{PHZ}	V_{EE}	V_{CC}
t _{PLZ}	V_{CC}	V_{EE}
others	open	pulse

FAMILY	AMPLITUDE	V _M	t _r ; t _f	
			f _{max} ; PULSE WIDTH	OTHER
74HC	V _{CC}	50%	< 2 ns	6 ns
74HCT	3.0 V	1.3 V	< 2 ns	6 ns

C_L = load capacitance including jig and probe capacitance (see AC CHARACTERISTICS for values).

R_T = termination resistance should be equal to the output impedance Z_0 of the pulse generator.

$t_r = t_f = 6 \text{ ns}$; when measuring f_{\max} , there is no constraint on t_r , t_f with 50% duty factor.

Fig.21 Input pulse definitions.

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PACKAGE OUTLINES

See *"74HC/HCT/HCU/HCMOS Logic Package Outlines"*.